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PATENT  
450100-05033

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicants: Mitsutoshi SHINKAI et al.  
International Application No.: PCT/JP04/004877  
International Filing Date: April 2, 2004  
For: RECORDING CONTROL APPARATUS AND  
METHOD, PROGRAM, AND STORAGE MEDIUM

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**INFORMATION DISCLOSURE STATEMENT**

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Sir:

Enclosed are copies of the publications, which were cited in the International Search Report of International Application No. PCT/JP04/004877. Also enclosed is a copy of Form PTO-1449 and the International Search Report.

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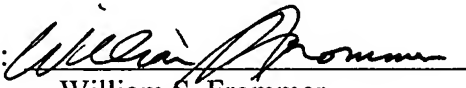
**REMARKS**

Entry of this Information Disclosure Statement and an early examination on the merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

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Enclosures

Based on Form PTO-1449 (3/90)	ATTY. DOCKET NO. 450100-05033	SERIAL NO. <b>10/516678</b> Filed Concurrently Herewith
	APPLICANT Mitsutoshi SHINKAI et al.	
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LIST OF REFERENCES CITED BY APPLICANT  
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	AA						
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AG	JP 2003-78872	03/14/03	Japan			
	AH	EP 1 278 371	01/22/03	Europe			
	AI	JP 2001-189940	07/10/01	Japan			
	AJ	EP 1 102 493	05/23/01	Europe			
	AK	JP 2001-333379	11/30/01	Japan			
	AL	EP 1 098 522	05/09/01	Europe			
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	AN	EP 1 102 276	05/23/01	Europe			
	AO	EP 1 102 277	05/23/01	Europe			
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